

Resource Summary Report

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JEOL: CRYO ARM 300 Transmission Electron Microscope

RRID:SCR_020163

Type: Tool

Proper Citation

JEOL: CRYO ARM 300 Transmission Electron Microscope (RRID:SCR_020163)

Resource Information

URL: <https://www.jeolusa.com/PRODUCTS/Transmission-Electron-Microscopes-TEM/300-kV/CRYO-ARM-300>

Proper Citation: JEOL: CRYO ARM 300 Transmission Electron Microscope (RRID:SCR_020163)

Description: Transmission electron microscope field emission cryo electron microscope that allows for automated detection of holes on specimen grid for automated, unattended acquisition of high resolution images

Resource Type: instrument resource

Keywords: Jeol, JEOL, Transmission Electron Microscope, Instrument Equipment, USEDit,

Availability: Commercially available

Resource Name: JEOL: CRYO ARM 300 Transmission Electron Microscope

Resource ID: SCR_020163

Alternate IDs: Model_Number_CRYO ARM 300

Record Creation Time: 20220129T080349+0000

Record Last Update: 20260725T190924+0000

Ratings and Alerts

No rating or validation information has been found for JEOL: CRYO ARM 300 Transmission Electron Microscope.

No alerts have been found for JEOL: CRYO ARM 300 Transmission Electron Microscope.

Data and Source Information

Source: [SciCrunch Registry](#)

Usage and Citation Metrics

We have not found any literature mentions for this resource.